

Thermographic testing (TT) — Levels 1, 2 and 3

The thermographic testing training shall be in accordance with Tables 17 and 18.

Table 17 — General content

Content	Level 1 (% of total duration)	Level 2 (% of total duration)	Level 3 (% of total duration)
13.1 Introduction to terminology and history of thermographic testing (TT)	1	1	1
13.2 Physical principles of the method and associated knowledge	1	2	1
13.3 Product knowledge and capabilities of the method and its derived techniques	3	0	2
13.4 Equipment	15	9	13
13.5 Information prior to testing	1	11	13
13.6 Testing	30	26	18
13.7 Evaluation and reporting	10	7	11
13.8 Assessment	0	5	6
13.9 Quality aspects	1	4	7
13.10 Developments	0	1	5

Table 18 — Thermographic testing (TT) — Levels 1, 2 and 3

Content		Level 1	Level 2	Level 3	
13.1 Introduction to terminology and history of thermographic testing (TT)	History	X	X	X	
	Purpose of NDT	What is testing?	X	X	X
		V	X	X	X
		A	X	X	X
		p			
		H	X	X	X
		V	X	X	X
	Purpose of thermographic testing (TT)	M	X	X	X
		D	X	X	X
	Terminology	A	X	X	X
		X	X	X	
13.2 Physical principles and associated knowledge	Heat transfer	H	X	X	
		T	X	X	
		P	X	X	
		—	X	X	
		—	X	X	
		— Gas	X	X	
		Variations of temperature scale	X	X	

		Heat conduction fundamentals	X	X	
		— Fourier's law	X	X	
		Heat convection fundamentals	X	X	
		— Newton's law of cooling	X	X	
		Heat radiation fundamentals	X	X	
		— Plank's law	X	X	
		— Wien's law	X	X	
		— Stefan-Boltzmann law	X	X	
		Emissivity	X	X	
		—	X		
		—		X	
	Infrared engineering	Emissivity	X		
		—	X		
		Temperature	X		
		Emissivity	X		
		Reflection	X		
		Transmission	X		
		Absorption	X		
		Black body	X		
		—		X	
		Kirchhoff's law	X		
		Color	X		
		Absorption	X		
		Transmission	X		
		Emissivity	X		
		Spectral emissivity	X	X	X
		Temperature		X	X
		Temperature		X	X
		Temperature		X	X
		Absorption		X	X
		—		X	X
		—			X
		Lambert's law		X	X
		Measurement		X	X
	—		X	X	
	—			X	
	—			X	
	—			X	
13.3 Product knowledge and related capability of the method and derived techniques	Principles of thermography	Concepts	X	X	
		Techniques	X	X	
		— Adiabatic temperature field	X	X	
		— Delamination/crack	X	X	
		— Self-heating	X	X	
		— Cavity radiation effect	X	X	
		— Active method	X	X	
		— Passive method	X	X	
	— Qualitative thermography	X	X		

		— Quantitative thermography	X	X		
		Selection criteria of technique		X	X	
		Other temperature measurement equipment and their measurement principles			X	
		Advantages	X	X	X	
	Thermoelastic stress measuring method	T			X	X
		P			X	X
		L				X
		T i				X
		T n				X
		S				X
		L				X
	Various flaws and their cause	F d		X	X	
		M		X	X	
		P		X	X	
		E		X	X	
		M		X	X	
		D n s				X
		C				X
		C (v)				X
	13.4 Equipment	Thermographic instrument	B f	X		
C			X			
—			X			
—			X			
F			X			
M d			X	X		
—			X			
—			X			
M t				X	X	
(
M t				X	X	
(
F			X			
Knowledge of image processing			X			
— Color palettes			X			
— Frame averaging	X	X				
— Pixel correction	X					
Signal process flow in instruments		X				

		Selection criteria of thermal loading device		X	
		Thermoelastic stress measuring method		X	
		Efficiency			X
		Uniformity			X
		Repeatability			X
		Scalability			X
13.5 Information prior to test	Information about the test object	Identification	X	X	X
		–	X	X	X
		–	X	X	X
		–		X	X
		–	X	X	X
	Test conditions and application of standard	Application		X	X
		Identification			X
		Preparation		X	X
		Application		X	X
		Scalability			X
		Software		X	X
		Repeatability		X	X
		Automation			X
	Technique and sequence of performing test	Sequence		X	
		Software		X	
		Preparation		X	
	Instructions	Preparation			X
		Preparation		X	
		Preparation			
		Preparation	X		
Documentation				X	
Preparation				X	
Control					
13.6 Testing	Test condition	Efficiency	X		
		Repeatability	X		
		Repeatability		X	
		–	X	X	
		–	X	X	
		Identification		X	
		Automated testing in production line scanner			X
		Control and adjustment of production process			X
		FEM simulation for parameter expansion, prediction of results and reconstruction			X

	Operation of infrared instruments	Setting of emissivity	X		
		Knowledge of sensor correction	X		
		Understanding of spatial resolution	X		
		Face angle dependence of emissivity		X	
		Temperature dependence of emissivity	X		
		Temperature dependence of sensor		X	
		Reflection	X		
		Refractive index	X		
		Scattering	X		
		Interference	X		
		Absorption	X		
		Fluctuation	X		
		Multiplexing	X	X	
		View factor	X	X	
	Scattering coefficient	X	X		
	Correction	X	X		
	Fluctuation	X	X		
	Special cases	Temperature			X
		Concentration			X
		Temperature			X
Fluctuation				X	
Concentration				X	
Various flaws and their cause	Fluctuation	X	X		
	Fluctuation	X	X		
	Multiplexing	X	X		
	Fluctuation	X	X		
	Fluctuation	X	X		
	Multiplexing	X	X		
13.7 Evaluation and reporting	Data processing	View factor	X		
		Temperature		X	
		Absorption		X	
		Fluctuation		X	
		Scattering		X	
		Interference		X	
		Motion compensation		X	
		Trend processing		X	
	Selection criteria of data processing flow		X		
	Recording	Requirements	X	X	
Reporting	Requirements	X	X		
	Characterization		X		

		Interpretation of indications		X	
		Evaluation of indications		X	
	Use of complimentary NDT methods	Interpretation of relevant standards and codes			X
		Evaluation (conventional approach, validated methods)			X
		D			X
		A			X
		L			X
S			X		
13.8 Assessment	Evaluation and confirmation of test reports	A		X	
		—		X	
		st			
		p			
		—			X
		cl			X
13.9 Quality aspects	Personnel qualification	IS	X	X	X
		O			X
	Documentation	cc			X
		F			X
		p			
		Q			X
		p			
		A			X
		in			
		p			
	D		X		
	V	X			
	in				
	T		X	X	
R		X	X		
Knowledge of applicable NDT application and product standards	C		X		
	U		X		
	N		X	X	
	J	X	X	X	
	E	X	X	X	
13.10 Developments	General information		X		
	Newest developments	Industrial applications			X
		Scientific applications			X